International IOR Rectifier

IRF6636PbF IRF6636TRPbF

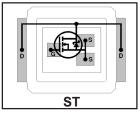
DirectFET™ Power MOSFET ② RoHs Compliant ①

Lead-Free (Qualified up to 260°C Reflow)

- Application Specific MOSFETs
- Ideal for CPU Core DC-DC Converters
- Low Conduction Losses
- High Cdv/dt Immunity
- Low Profile (<0.7mm)
- Dual Sided Cooling Compatible ①
- Compatible with existing Surface Mount Techniques ①

Typical values (unless otherwise specified)

V _{DSS}		V _G	S	$R_{DS(on)}$		R	OS(on)	
20V ma	Χ	±20V	max	3.2mΩ@ 10V		3.2mΩ@ 10V 4.6mΩ@		Ω@ 4.5V
$Q_{g tot}$		\mathbf{Q}_{gd}	Q	gs2	Q_{rr}	(Q_{oss}	$V_{gs(th)}$
18nC	(6.1nC	1.9	nC	7.3nC		10nC	1.8V





Applicable DirectFET Outline and Substrate Outline (see p.7,8 for details) ①

 				1 /			
SQ	SX	ST	MQ	MX	MT		

Description

The IRF6636PbF combines the latest HEXFET® Power MOSFET Silicon technology with the advanced DirectFET™ packaging to achieve the lowest on-state resistance in a package that has the footprint of a MICRO-8 and only 0.7 mm profile. The DirectFET package is compatible with existing layout geometries used in power applications. PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET package allows dual sided cooling to maximize thermal transfer in power systems, improving previous best thermal resistance by 80%.

The IRF6636PbF balances both low resistance and low charge along with ultra low package inductance to reduce both conduction and switching losses. The reduced total losses make this product ideal for high efficiency DC-DC converters that power the latest generation of processors operating at higher frequencies. The IRF6636PbF has been optimized for parameters that are critical in synchronous buck operating from 12 volt buss converters including Rds(on) and gate charge to minimize losses in the control FET socket.

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	20	V
V_{GS}	Gate-to-Source Voltage	±20	
D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V 3	18	
D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V 3	15	Α
_D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V ④	81	
DM	Pulsed Drain Current ®	140	
E _{AS}	Single Pulse Avalanche Energy ®	28	mJ
I _{AR}	Avalanche Current S	14	Α

6.0

5.0

4.0

I_D= 14A

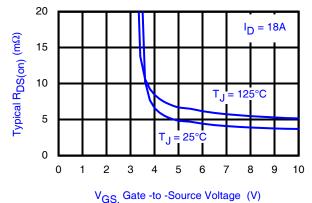


Fig 1. Typical On-Resistance vs. Gate Voltage

/_{GS}, Gate-to-Source Voltage (V) 3.0 2.0 1.0 0.0 0 10 Q_G Total Gate Charge (nC)

Fig 2. Typical Total Gate Charge vs. Gate-to-Source Voltage

Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET Website.
- 3 Surface mounted on 1 in. square Cu board, steady state. www.irf.com
- T_C measured with thermocouple mounted to top (Drain) of part.

V_{DS}= 16V

 $V_{DS} = 10V$

- S Repetitive rating; pulse width limited by max. junction temperature.
- © Starting $T_J = 25$ °C, L = 0.27mH, $R_G = 25\Omega$, $I_{AS} = 14$ A.

30

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		15		mV/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		3.2	4.5	mΩ	$V_{GS} = 10V, I_{D} = 18A$ ⑦
			4.6	6.4		$V_{GS} = 4.5V, I_D = 14A$ ⑦
$V_{GS(th)}$	Gate Threshold Voltage	1.55		2.45	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient		-6.4		mV/°C	
I _{DSS}	Drain-to-Source Leakage Current			1.0	μΑ	$V_{DS} = 16V, V_{GS} = 0V$
				150		$V_{DS} = 16V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-100		V _{GS} = -20V
gfs	Forward Transconductance	52			S	$V_{DS} = 10V, I_{D} = 14A$
Q_g	Total Gate Charge		18	27		
Q_{gs1}	Pre-Vth Gate-to-Source Charge		5.9			$V_{DS} = 10V$
Q_{gs2}	Post-Vth Gate-to-Source Charge		1.9		nC	$V_{GS} = 4.5V$
Q_{gd}	Gate-to-Drain Charge		6.1			I _D = 14A
Q_{godr}	Gate Charge Overdrive		4.1			See Fig. 15
Q _{sw}	Switch Charge (Q _{gs2} + Q _{gd})		8.0			
Q _{oss}	Output Charge		10		nC	$V_{DS} = 10V$, $V_{GS} = 0V$
R_{G}	Gate Resistance			1.5	Ω	
t _{d(on)}	Turn-On Delay Time		14			$V_{DD} = 16V, V_{GS} = 4.5V$ ⑦
t _r	Rise Time		19			I _D = 14A
t _{d(off)}	Turn-Off Delay Time		16		ns	Clamped Inductive Load
t _f	Fall Time		6.2			See Fig. 16 & 17
C _{iss}	Input Capacitance		2420			$V_{GS} = 0V$
C _{oss}	Output Capacitance		780		рF	$V_{DS} = 10V$
C _{rss}	Reverse Transfer Capacitance		360			f = 1.0MHz

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			52		MOSFET symbol
	(Body Diode)				Α	showing the
I _{SM}	Pulsed Source Current			140		integral reverse
	(Body Diode) 3					p-n junction diode.
V_{SD}	Diode Forward Voltage		_	1.0	V	$T_J = 25^{\circ}C, I_S = 14A, V_{GS} = 0V ?$
t _{rr}	Reverse Recovery Time		16	24	ns	$T_J = 25^{\circ}C, I_F = 14A$
Q_{rr}	Reverse Recovery Charge		7.3	11	nC	di/dt = 100A/µs ⑦ See Fig. 18

Notes:

2 www.irf.com

 $[\]ensuremath{\mathfrak{D}}$ Repetitive rating; pulse width limited by max, junction temperature.

Absolute Maximum Ratings

	Parameter	Max.	Units
P _D @T _A = 25°C	Power Dissipation 3	2.2	W
P _D @T _A = 70°C	Power Dissipation 3	1.4	
$P_D @ T_C = 25^{\circ}C$	Power Dissipation ®	42	
T _P	Peak Soldering Temperature	270	°C
TJ	Operating Junction and	-40 to + 150	
T _{STG}	Storage Temperature Range		

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③ ⊙		58	
$R_{\theta JA}$	Junction-to-Ambient	12.5		
$R_{\theta JA}$	Junction-to-Ambient ® O	20		°C/W
$R_{\theta JC}$	Junction-to-Case 4 0		3.0	
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted	1.0		
	Linear Derating Factor ③	0.	017	W/°C

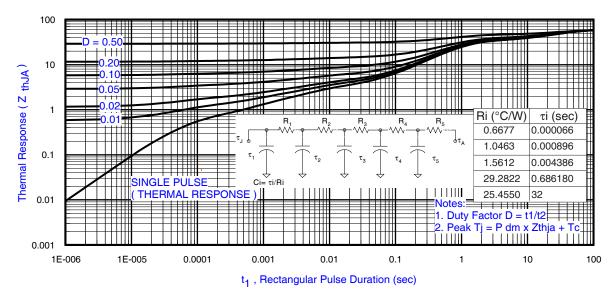
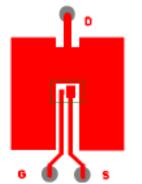


Fig 3. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Notes:

- Used double sided cooling , mounting pad.
- ® Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- $\mathbf{0}$ R_{θ} is measured at T_J of approximately 90°C.



③ Surface mounted on 1 in. square Cu (still air).



Mounted to a PCB with small clip heatsink (still air)



Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

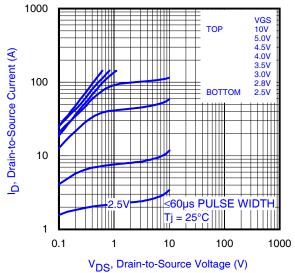


Fig 4. Typical Output Characteristics

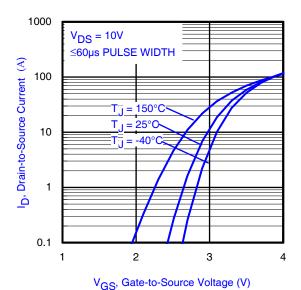


Fig 6. Typical Transfer Characteristics

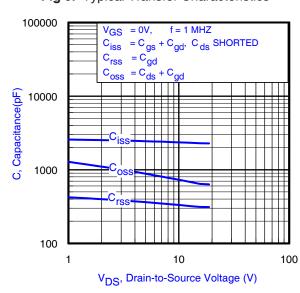


Fig 8. Typical Capacitance vs.Drain-to-Source Voltage

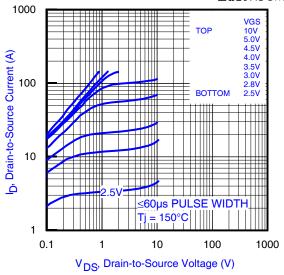


Fig 5. Typical Output Characteristics

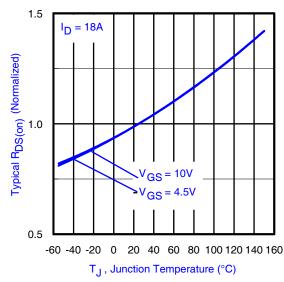


Fig 7. Normalized On-Resistance vs. Temperature

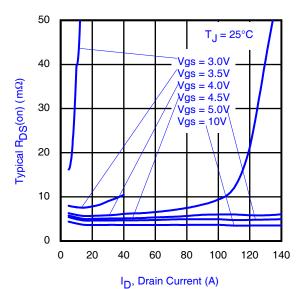


Fig 9. Typical On-Resistance vs.
Drain Current and Gate Voltage

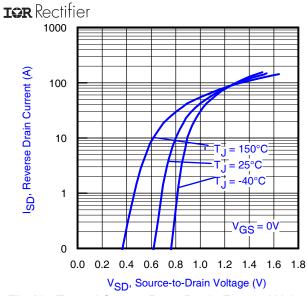


Fig 10. Typical Source-Drain Diode Forward Voltage

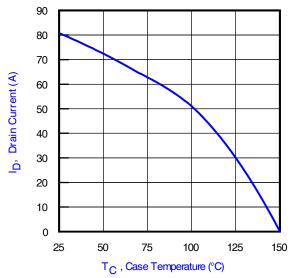


Fig 12. Maximum Drain Current vs. Case Temperature

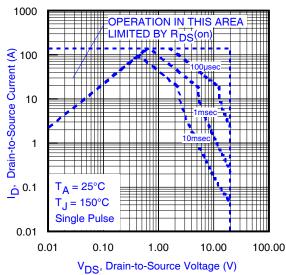


Fig11. Maximum Safe Operating Area

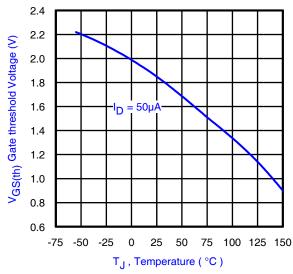


Fig 13. Threshold Voltage vs. Temperature

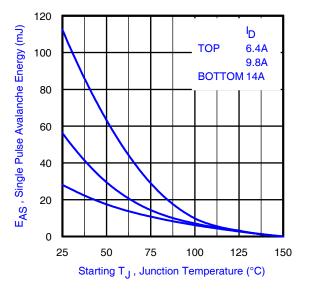


Fig 14. Maximum Avalanche Energy vs. Drain Current

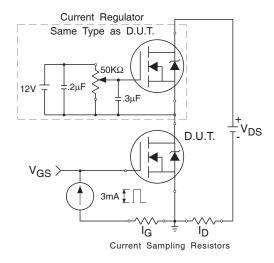


Fig 15a. Gate Charge Test Circuit

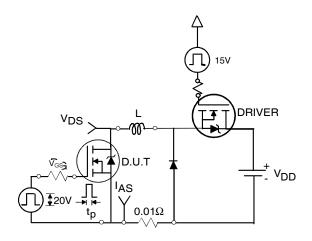


Fig 16a. Unclamped Inductive Test Circuit

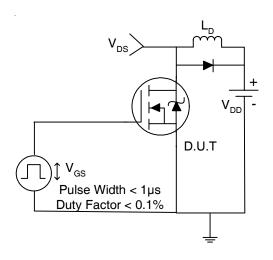


Fig 17a. Switching Time Test Circuit

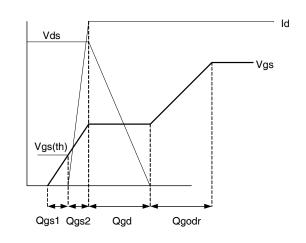


Fig 15b. Gate Charge Waveform

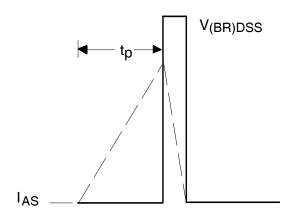


Fig 16b. Unclamped Inductive Waveforms

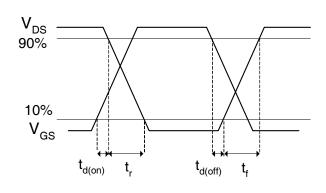


Fig 17b. Switching Time Waveforms

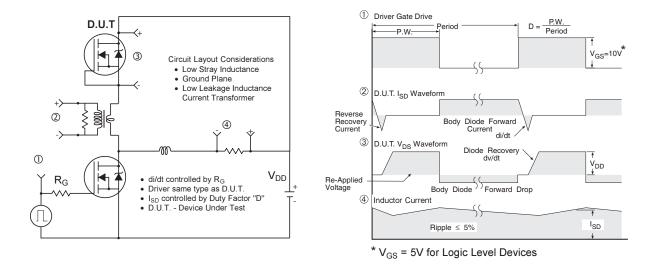
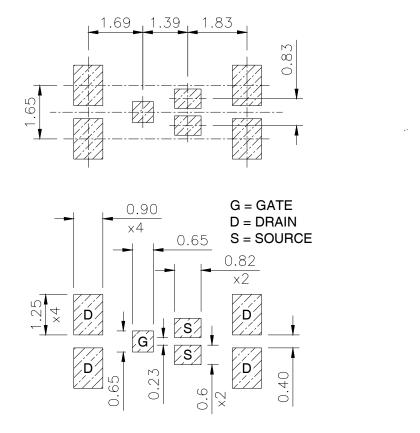


Fig 18. Diode Reverse Recovery Test Circuit for N-Channel HEXFET® Power MOSFETs

DirectFET™ Substrate and PCB Layout, ST Outline ③ (Small Size Can, T-Designation).

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET.

This includes all recommendations for stencil and substrate designs.



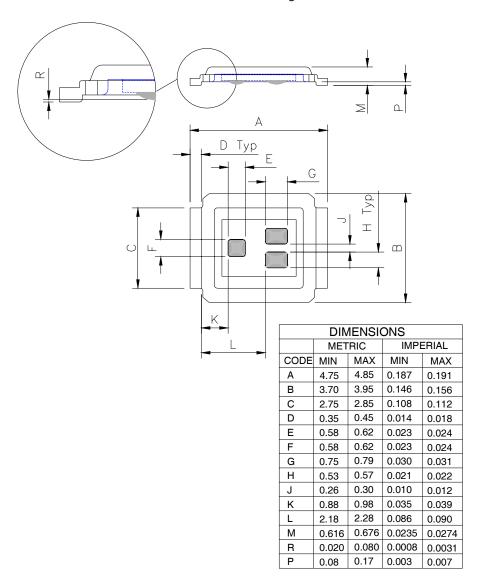
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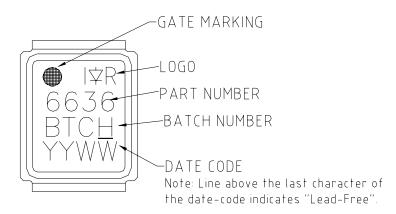
DirectFET™ Outline Dimension, ST Outline (Small Size Can, T-Designation).

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET.

This includes all recommendations for stencil and substrate designs.

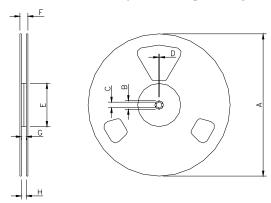


DirectFET™ Part Marking



8 www.irf.com

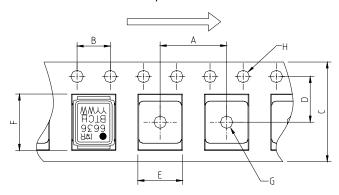
DirectFET™ Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as IRF6636TRPBF). For 1000 parts on 7" reel, order IRF6636TR1PBF

	REEL DIMENSIONS								
S.	TANDARI	O OPTION	(QTY 48	00)	TR	1 OPTION	(QTY 10	00)	
	ME	TRIC	IMP	ERIAL	ME	ETRIC	IMPERIAL		
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Α	330.0	N.C	12.992	N.C	177.77	N.C	6.9	N.C	
В	20.2	N.C	0.795	N.C	19.06	N.C	0.75	N.C	
С	12.8	13.2	0.504	0.520	13.5	12.8	0.53	0.50	
D	1.5	N.C	0.059	N.C	1.5	N.C	0.059	N.C	
Е	100.0	N.C	3.937	N.C	58.72	N.C	2.31	N.C	
F	N.C	18.4	N.C	0.724	N.C	13.50	N.C	0.53	
G	12.4	14.4	0.488	0.567	11.9	12.01	0.47	N.C	
Н	11.9	15.4	0.469	0.606	11.9	12.01	0.47	N.C	

Loaded Tape Feed Direction



DIMENSIONS								
	ME	TRIC	IMP	ERIAL				
CODE	MIN	MAX	MIN	MAX				
Α	7.90	8.10	0.311	0.319				
В	3.90	4.10	0.154	0.161				
С	11.90	12.30	0.469	0.484				
D	5.45	5.55	0.215	0.219				
E	4.00	4.20	0.158	0.165				
F	5.00	5.20	0.197	0.205				
G	1.50	N.C	0.059	N.C				
Н	1.50	1.60	0.059	0.063				

Data and specifications subject to change without notice.

This product has been designed and qualified for the Consumer market.

Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Note: For the most current drawings please refer to the IR website at: http://www.irf.com/package/